

# Micropower, Dual, Single Supply Precision Op Amp

## DESCRIPTION

The RH1078M is a micropower dual op amp in the standard 8-pin configuration. This device is optimized for single supply operation at 5V. Specifications for  $\pm 15V$  are also provided.

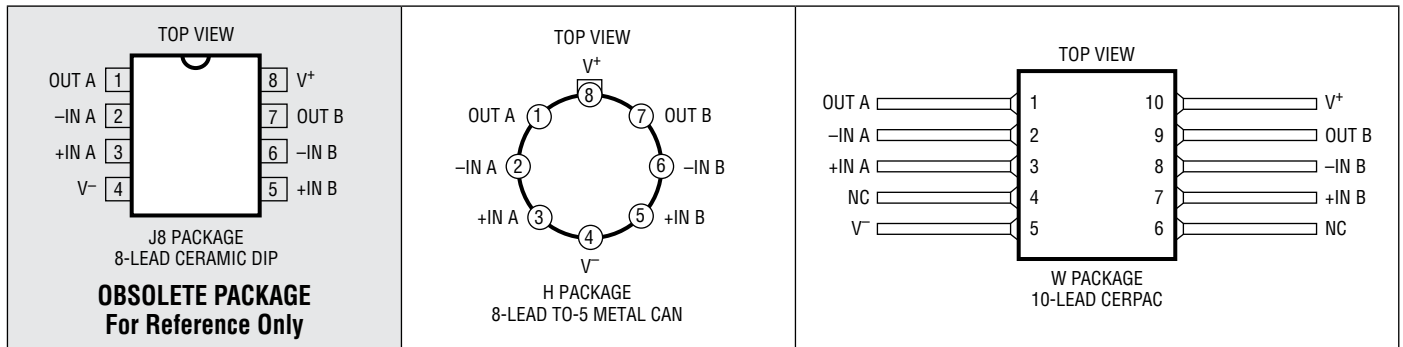
The wafer lots are processed to ADI's in-house Class S flow to yield circuits usable in stringent military applications.

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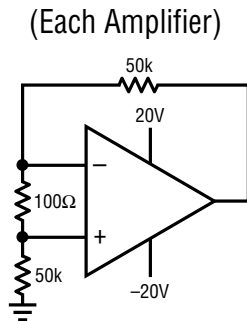
## ABSOLUTE MAXIMUM RATINGS

Supply Voltage.....	$\pm 22V$
Differential Input Voltage .....	$\pm 30V$
Input Voltage.....	Equal to Positive Supply Voltage 0.5V Below Negative Supply Voltage
Output Short-Circuit Duration .....	Indefinite
Operating Temperature Range .....	$-55^{\circ}C$ to $125^{\circ}C$
Storage Temperature Range .....	$-55^{\circ}C$ to $150^{\circ}C$
Lead Temperature (Soldering, 10 sec).....	$300^{\circ}C$

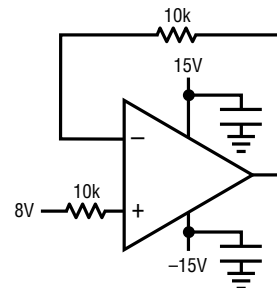
## PACKAGE/ORDER INFORMATION



## BURN-IN CIRCUIT



## TOTAL DOSE BIAS CIRCUIT



Note: For ordering information contact LTC.

**TABLE 1: ELECTRICAL CHARACTERISTICS** (Preirradiation) $V_S = 5V$ ,  $V_{CM} = 0.1V$ ,  $V_{OUT} = 1.4V$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	NOTES	$T_A = 25^\circ\text{C}$			SUB-GROUP	$-55^\circ\text{C} \leq T_A \leq 125^\circ\text{C}$			SUB-GROUP	UNITS	
				MIN	TYP	MAX		MIN	TYP	MAX			
$V_{OS}$	Input Offset Voltage					120	4			370	2, 3	$\mu\text{V}$	
$\frac{\Delta V_{OS}}{\Delta \text{Temp}}$	Average Tempco of Offset Voltage									0.5		$\mu\text{V}/^\circ\text{C}$	
$\frac{\Delta V_{OS}}{\Delta \text{Time}}$	Long-Term $V_{OS}$ Stability					0.5						$\mu\text{V}/\text{Month}$	
$I_{OS}$	Input Offset Current					0.8	1			1.5	2, 3	nA	
$I_B$	Input Bias Current					15	1			18	2, 3	nA	
$e_n$	Input Noise Voltage	0.1Hz to 10Hz	1			0.5						$\mu\text{V}_{p-p}$	
	Input Noise Voltage Density	$f_0 = 10\text{Hz}$ $f_0 = 1\text{kHz}$	1 1			25 24						$\text{nV}/\sqrt{\text{Hz}}$ $\text{nV}/\sqrt{\text{Hz}}$	
$i_n$	Input Noise Current	0.1Hz to 10Hz	1			2.6						$\text{pA}_{p-p}$	
	Input Noise Current Density	$f_0 = 10\text{Hz}$ $f_0 = 1\text{kHz}$	1 1			0.07 0.025						$\text{pA}/\sqrt{\text{Hz}}$ $\text{pA}/\sqrt{\text{Hz}}$	
$R_{IN}$	Input Resistance Differential		2			600						$\text{M}\Omega$	
	Common Mode		2			5						$\text{G}\Omega$	
	Input Voltage Range		2 2			3.5 0	1 1			3.20 0.05	2, 3 2, 3	V V	
CMRR	Common Mode Rejection Ratio	$V_{CM} = 0\text{V to } 3.5\text{V}$ $V_{CM} = 0.05\text{V to } 3.2\text{V}$				94	1			88	2, 3	dB dB	
PSRR	Power Supply Rejection Ratio	$V_S = 2.3\text{V to } 12\text{V}$ $V_S = 3.1\text{V to } 12\text{V}$				100	1			94	2, 3	dB dB	
$A_{VOL}$	Large-Signal Voltage Gain	$V_O = 0.03\text{V to } 4\text{V}$ , No Load				150	1					V/mV	
		$V_O = 0.03\text{V to } 3.5\text{V}$ , $R_L = 50\text{k}$				120	1					V/mV	
		$V_O = 0.05\text{V to } 4\text{V}$ , No Load								80	2, 3	V/mV	
		$V_O = 0.05\text{V to } 3.5\text{V}$ , $R_L = 50\text{k}$								60	2, 3	V/mV	
$V_{OUT}$	Output Voltage Swing	Output Low, No Load								8	5, 6	mV	
		Output Low, 2k to GND										mV	
		Output Low, $I_{SINK} = 100\mu\text{A}$									170	5, 6	mV
		Output High, No Load				4.2				3.9	5, 6	V	
		Output High, 2k to GND				3.5				3.0	5, 6	V	
SR	Slew Rate	$A_V = 1$ , $V_S = \pm 2.5\text{V}$				0.04	4					V/ $\mu\text{s}$	
GBW	Gain-Bandwidth Product	$f_0 \leq 20\text{kHz}$				200						kHz	
$I_S$	Supply Current	per Amplifier				75	1			95	2, 3	$\mu\text{A}$	
	Channel Separation	$\Delta V_{IN} = 3\text{V}$ , $R_L = 10\text{k}$				130						dB	
	Minimum Supply Voltage		3			2.3						V	

**TABLE 1: ELECTRICAL CHARACTERISTICS** (Preirradiation) $V_S = \pm 15V$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	NOTES	$T_A = 25^\circ\text{C}$			SUB-GROUP	$-55^\circ\text{C} \leq T_A \leq 125^\circ\text{C}$			SUB-GROUP	UNITS
				MIN	TYP	MAX		MIN	TYP	MAX		
$V_{OS}$	Input Offset Voltage					350	4			600	2, 3	$\mu\text{V}$
$\frac{\Delta V_{OS}}{\Delta \text{Temp}}$	Average Tempco of Offset Voltage									0.6		$\mu\text{V}/^\circ\text{C}$
$I_{OS}$	Input Offset Current					0.8	1			1.5	2, 3	nA
$I_B$	Input Bias Current					15				18	2, 3	nA
	Input Voltage Range			13.5 -15.0			1 1					V V
CMRR	Common Mode Rejection Ratio	$V_{CM} = 13.5V, -15V$		97			1					dB
		$V_{CM} = 13V, -14.9V$							90		2, 3	dB
PSRR	Power Supply Rejection Ratio	$V_S = 5V, 0V$ to $\pm 18V$		100			1		94		2, 3	dB
$A_{VOL}$	Large-Signal Voltage Gain	$V_O = \pm 10V, R_L = 50k$		1000			1					V/mV
		$V_O = \pm 10V, R_L = 2k$		300			1					V/mV
		$V_O = \pm 10V, R_L = 5k$							150		2, 3	V/mV
$V_{OUT}$	Output Voltage Swing	$R_L = 50k$		$\pm 13$			4					V
		$R_L = 2k$		$\pm 11$			4					V
		$R_L = 5k$							$\pm 11$		5, 6	V
SR	Slew Rate			0.06			4					V/ $\mu\text{s}$
$I_S$	Supply Current	per Amplifier				100	1			125	2, 3	$\mu\text{A}$

**Note 1:** All noise parameters are for  $V_S = \pm 2.5V$ ,  $V_O = 0V$ .**Note 2:** This parameter is guaranteed by design, characterization or correlation to other tested parameters.**Note 3:** Power supply rejection ratio is measured at the minimum supply voltage. The op amps actually work at 1.8V supply but with a typical offset skew of  $-300\mu\text{V}$ .

**TABLE 1A: ELECTRICAL CHARACTERISTICS** (Postirradiation) $V_S = 5V, 0V, V_{CM} = 0.1V, V_{OUT} = 1.4V, T_A = 25^\circ C$ , unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	10KRAD(Si)		25KRAD(Si)		50KRAD(Si)		75KRAD(Si)		100KRAD(Si)		UNITS
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
$V_{OS}$	Input Offset Voltage			120		175		250		500			$\mu V$
$I_{OS}$	Input Offset Current			2		8		13		18			nA
$I_B$	Input Bias Current			20		40		80		100			nA
	Input Voltage Range		3.5		3.5		3.5		3.5				V
CMRR	Common Mode Rejection Ratio	$V_{CM} = 0V$ to 3.5V		91		89		87		85			dB
PSRR	Power Supply Rejection Ratio	$V_S = 2.3V$ to 12V		100		100		98		88			dB
$A_{VOL}$	Large-Signal Voltage Gain	$V_O = 0.03V$ to 4V, No Load $V_O = 0.03V$ to 3.5V, $R_L = 50k$	150 120		150 50		100 20		50 10				V/mV V/mV
$V_{OUT}$	Output Voltage Swing	Output Low, No Load Output Low, 2k to GND Output Low, $I_{SINK} = 100\mu A$ Output High, No Load Output High, 2k to GND		6 2 130		9 2 140		13 2 150		20 2 160			mV mV mV V V
SR	Slew Rate	$A_V = 1, V_S = \pm 2.5V$		0.04		0.03		0.02		0.01			V/ $\mu s$
$I_S$	Supply Current	per Amplifier		75		75		75		75			$\mu A$

**TABLE 1A: ELECTRICAL CHARACTERISTICS** (Postirradiation)  
 $V_S = \pm 15V$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	10KRAD(Si)		25KRAD(Si)		50KRAD(Si)		75KRAD(Si)		100KRAD(Si)		UNITS
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
$V_{OS}$	Input Offset Voltage		350		500		650		800		1000		$\mu V$
$I_{OS}$	Input Offset Current		2		8		13		18		23		nA
$I_B$	Input Bias Current		20		40		80		100		120		nA
	Input Voltage Range		13.5	-15.0	13.5	-15.0	13.5	-15.0	13.5	-15.0	13.5	-15.0	V V
CMRR	Common Mode Rejection Ratio	$V_{CM} = 13.5V, -15V$	94		92		90		88		86		dB
PSRR	Power Supply Rejection Ratio	$V_S = 5V, 0V$ to $\pm 18V$	100		100		98		88		78		dB
$A_{VOL}$	Large-Signal Voltage Gain	$V_O = 10V, R_L = 50k$ $V_O = 10V, R_L = 2k$	1000	300	700	200	400	120	150	45	50	15	V/mV V/mV
$V_{OUT}$	Output Voltage Swing	$R_L = 50k$ $R_L = 2k$	$\pm 13$	$\pm 11$	$\pm 13$	$\pm 11$	$\pm 13$	$\pm 11$	$\pm 13$	$\pm 11$	$\pm 13$	$\pm 10$	V V
SR	Slew Rate		0.05		0.04		0.03		0.02		0.01		V/ $\mu s$
$I_S$	Supply Current	per Amplifier	100		100		100		100		100		$\mu A$

## TABLE 2: ELECTRICAL TEST REQUIREMENTS

MIL-STD-883 TEST REQUIREMENTS	SUBGROUP
Final Electrical Test Requirements (Method 5004)	1*,2,3,4,5,6
Group A Test Requirements (Method 5005)	1,2,3,4,5,6
Group C and D End Point Electrical Parameters (Method 5005)	1,2,3

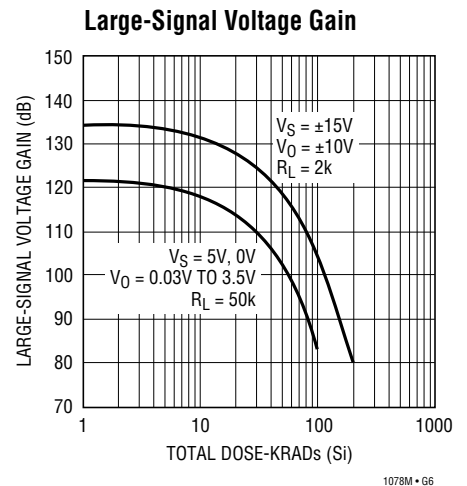
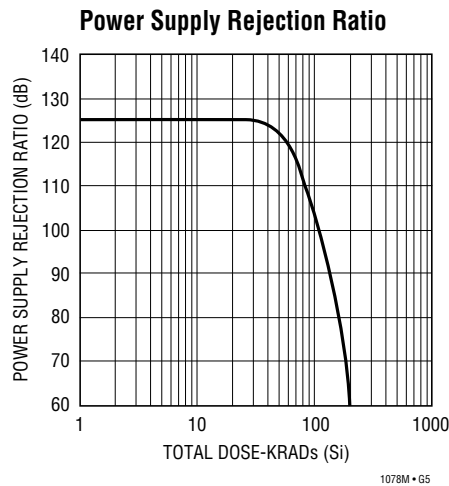
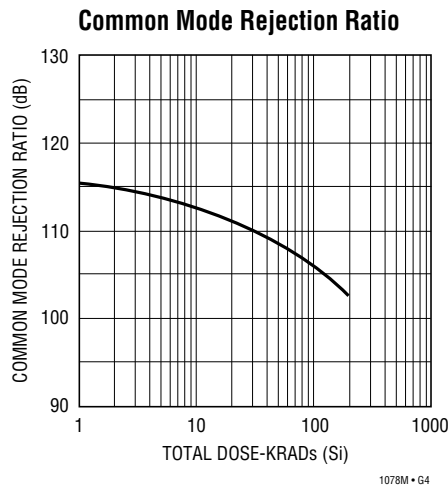
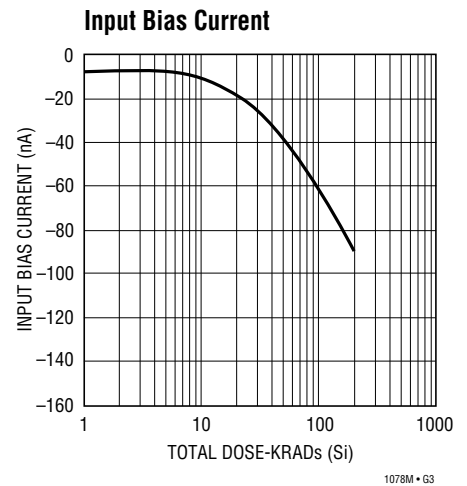
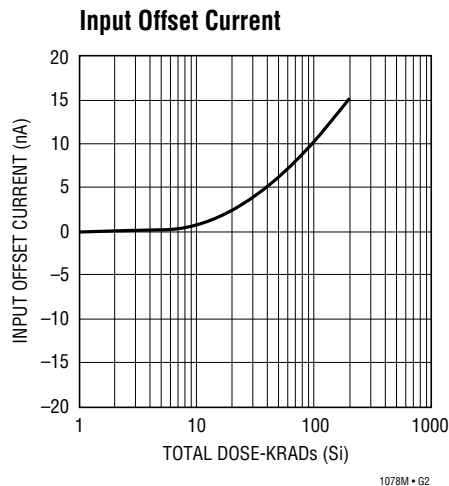
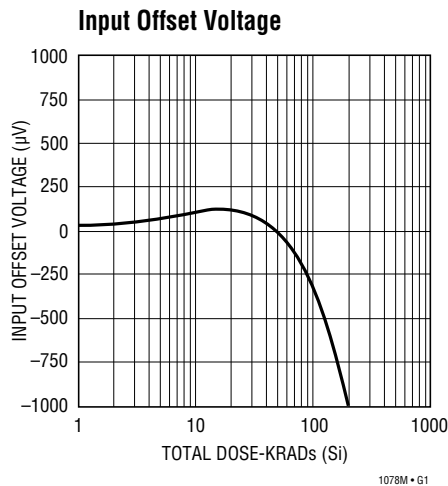
\*PDA Applies to subgroup 1. See PDA Test Notes.

### PDA Test Notes

The PDA is specified as 5% based on failures from group A, subgroup 1, tests after cooldown as the final electrical test in accordance with method 5004 of MIL-STD-883 Class B. The verified failures of group A, subgroup 1, after burn-in divided by the total number of devices submitted for burn-in in that lot shall be used to determine the percent for the lot.

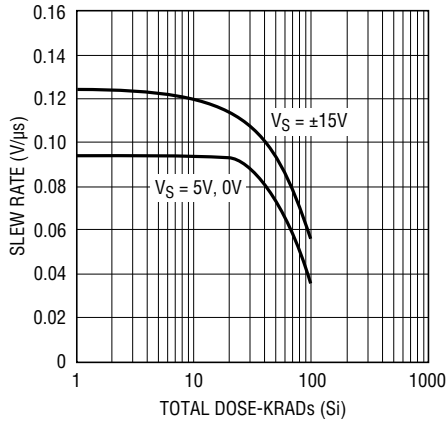
Analog Devices, Inc. reserves the right to test to tighter limits than those given.

## TYPICAL APPLICATIONS



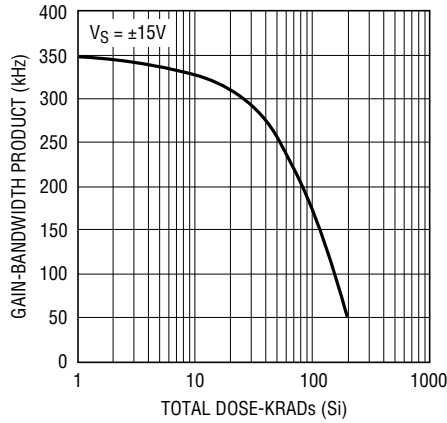
**TYPICAL APPLICATIONS**

**Slew Rate**



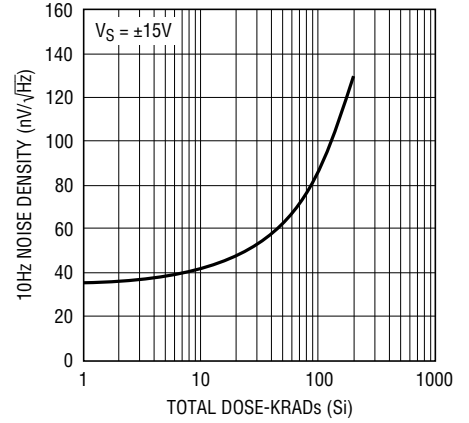
1078M • G7

**Gain-Bandwidth Product**



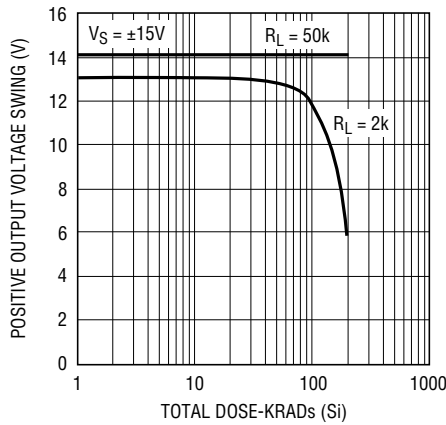
1078M • G8

**10Hz Noise Density**



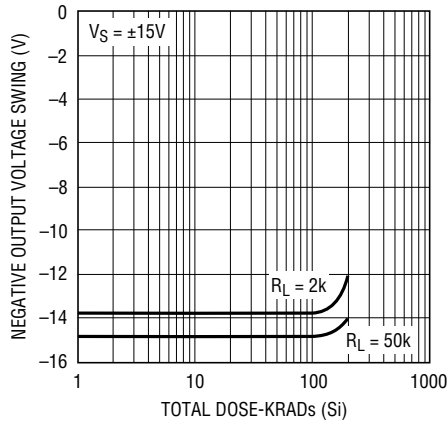
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**Positive Output Voltage Swing**



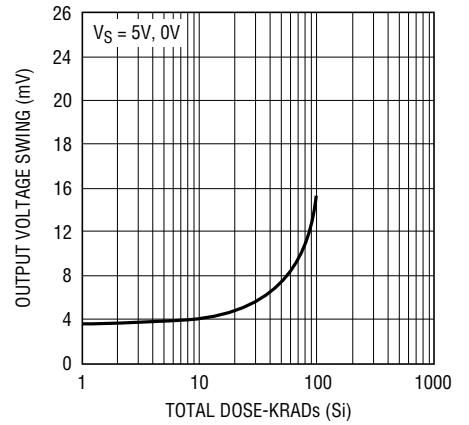
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**Negative Output Voltage Swing**



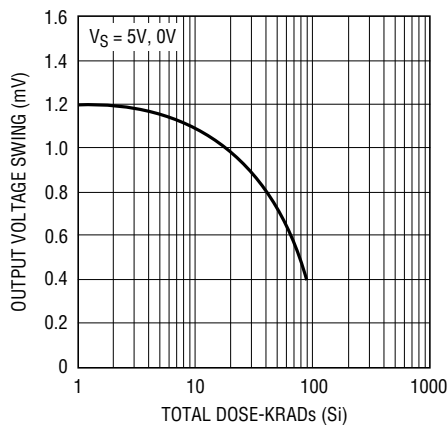
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**Output Voltage Swing Low, No Load**



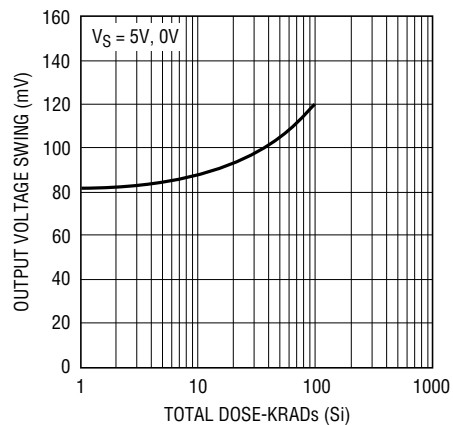
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**Output Voltage Swing Low, 2k to GND**



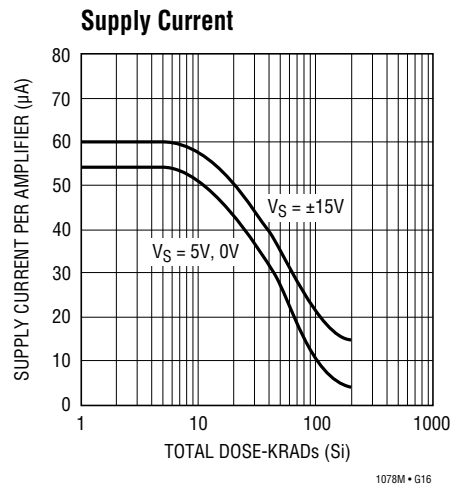
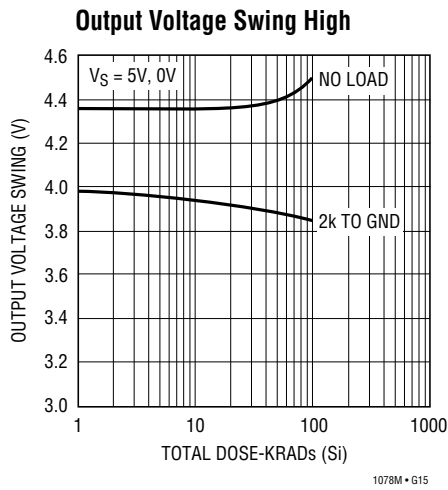
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**Output Voltage Swing Low, ISINK = 100mA**



1078M • G14

## TYPICAL APPLICATIONS



## REVISION HISTORY (Revision history begins at Rev F)

REV	DATE	DESCRIPTION	PAGE NUMBER
F	05/10	Added J8 and W Packages	1
G	03/19	Obsoleting J8 package and updating document to ADI format	All Pages